

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10813023	CHANG, YEN SHENG
	Examiner Bae, Ji H	Art Unit 2115

Notes	Date	Examiner
EAST text search (see attached search history)	7-19-2006	jb
U.S. Patent and Trademark Office		Part of Paper No.: 20060719

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Class	SubClass	Date	Examiner
713	1	7-19-2006	jb
713	2	7-19-2006	jb

U.S. Patent and Trademark Office

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